Notice of References Cited Application/Control No. 09/942,360 Examiner Harry Vartanian Applicant(s)/Patent Under Reexamination WIECK, CHRISTOPHER PETER Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0034217	10-2001	LOKE et al.	455/126
	В	US-2003/0139161	07-2003	Wieck, Christopher P.	455/234.1
	С	US-2004/0105511	06-2004	Wieck, Christopher P.	375/317
	D	US-5,722,061	02-1998	Hutchison et al.	455/245.1
	E	US-6,009,129	12-1999	Kenney et al.	375/346
	F	US-6,208,202	03-2001	Kaufman et al.	330/51
	G	US-6,271,722	08-2001	Ballantyne, Gary J.	330/51
	Н	US-6,313,698	11-2001	Zhang et al.	330/51
	ı	US-6,351,504	02-2002	Igarashi et al.	375/349
	J	US-6,445,247	09-2002	Walker, Gordon Kent	330/10
	к	US-6,529,716	03-2003	Eidson et al.	455/115.1
	L	US-6,668,028	12-2003	Wieck, Christopher Peter	375/349
	М	US-6,687,491	02-2004	Wieck, Christopher P.	455/234.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.